Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/037,164	CHEN ET AL.
Examiner	Art Unit
Jennifer N. To	2195

	SEARCHED			
Class	Subclass	Date	Examiner	
718	100-108	2/9/2006	JT	
707	10	2/9/2006	JT	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	,	<u> </u>	:

SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
INVENTOR NAME SEARCH	2/9/2006	JT
EAST UPDATE SEARCH	2/9/2006	JT